

SC5307A/SC5308A 100 kHz to 6 GHz RF Downconverter

Datasheet

PRODUCT SPECIFICATIONS

Definition of Terms

The following terms are used throughout this datasheet to define specific conditions:

Specification (spec)	Defines guaranteed performance of a calibrated instrument under the following conditions: <ul style="list-style-type: none">• 3 hours storage at room temperature (standardized to 25 °C) followed by 30 minutes minimum warm-up operation.• Specified environmental conditions are met within the specified operating temperature range of 0 °C to 40 °C unless otherwise noted.• Recommended calibration intervals are used.
Typical data (typ)	When used with <, > or in a range, defines performance met by approximately 80% of all instruments manufactured. This data is not guaranteed, does not include measurement uncertainty, and is valid only at room temperature (standardized to 25 °C).
Nominal values (nom)	Characterizes product performance by means of average performance of a representative value for the given parameter (e.g. nominal impedance). This data is not guaranteed and is valid only at room temperature (standardized to 25 °C).
Measured values (meas)	Characterizes expected product performance by means of measurement results gained from individual samples.

Specifications are subject to change without notice. For the most recent product specifications, visit www.signalcore.com.

Spectral Specifications

RF input range

RF amplifier disabled 100 kHz to 6.0 GHz

RF amplifier enabled 1 MHz to 6.0 GHz

IF2 input frequency 1.25 GHz

IF output center frequency⁽¹⁾

Last (3rd) stage conversion enabled 1 MHz to 500 MHz

Second IF selected (2 stage conversion) 1.25 GHz

IF output polarity⁽²⁾

Last (3rd) stage conversion enabled Non-inverted/Inverted

Second IF selected (2 stage conversion) Inverted

IF bandwidth (3 dB)

Last (3rd) stage conversion enabled 80/160 MHz

Second IF selected (2 stage conversion) 320 MHz

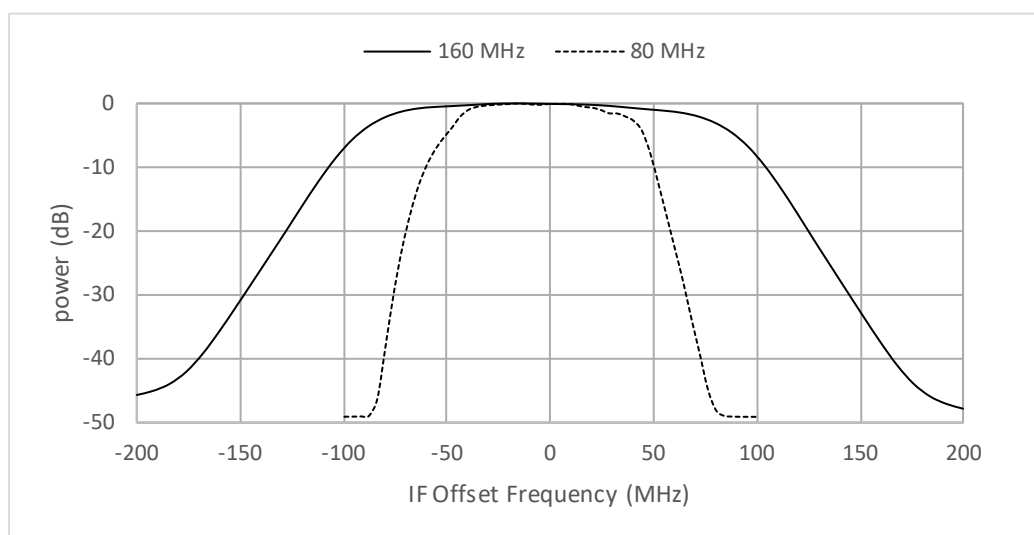


Figure 1. Typical relative output IF responses of bandpass filters measured at tuned center IF of 240 MHz. The noise floor of the power meter limits the out-of-band rejection measurement.

- (1) The final IF may be selected from either the input RF, second, or third conversion stages. IF the input RF port is selected, the signal from the RF port is directly routed to the final IF port, bypassing the conversion process entirely. The frequency range of this path is 100 kHz to 500 MHz. When the second stage is selected, the final IF is fixed at 1.25 GHz, and the spectrum is inverted. When the third stage is selected, the IF center frequency is tunable from 1 MHz to 500 MHz in 5 MHz steps. Although the tuning range provides flexibility, the IF bandwidth may practically limit the center frequency.
- (2) The IF output polarity refers to the conversion polarity of the downconverter. When the polarity is inverted, the spectral content of the output is inverted with respect to the input; this process is commonly known as “spectral inversion” or “spectral flipping”. The choice depends on the application. For digitizers that are sampling the IF in the even order Nyquist zones that naturally inverting spectra, having the IF polarity inverted will produce non-inverted baseband, and vice-versa. However, this is only a convenience in this application case because inverted spectrum, once digitized, can easily be re-inverted mathematically. This inversion is only available when the third conversion stage is selected. When the final IF signal is taken from the second IF stage (2 stage conversion), the output spectrum is always inverted.

RF tuning

Frequency step resolution ⁽³⁾ 1 Hz
 Lock and settling times ⁽⁴⁾ 1 ms

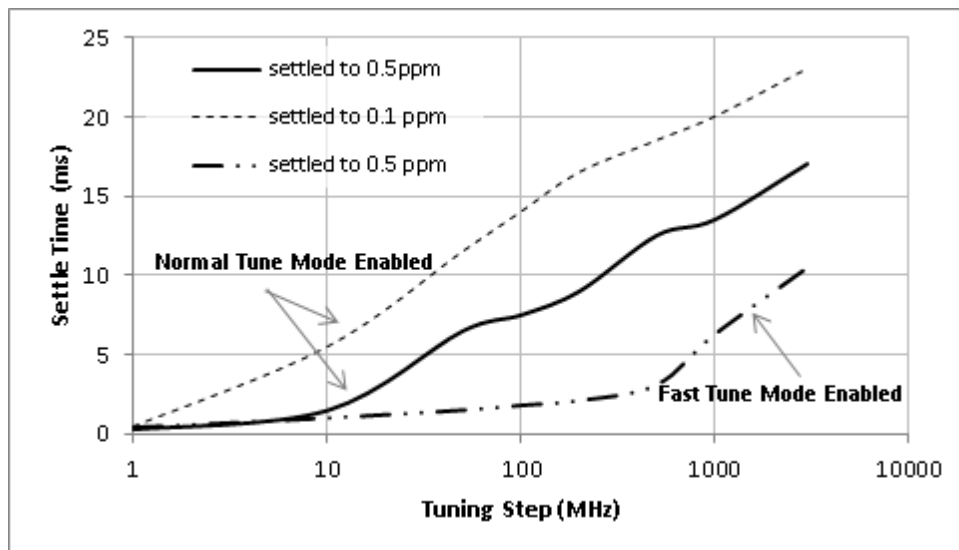


Figure 2. Typical frequency settling time versus tuning step frequency.

- (3) Tuning resolution of 1 MHz is available.
- (4) Locked and settled to < 1 ppm of final frequencies of > 500 MHz and step size of < 10 MHz. For final frequencies < 500 MHz the settle time applies to accuracy with 500 Hz of the final frequency for a 10 MHz step. See Figure 2 for examples of other tuning step settling times. When fast-tune mode is enabled the noise damping capacitor across the main YIG tuning coil is disengaged, resulting in an increase of the rate of current flow through the coil and settling to a steady state quicker. Lock time begins when the full tuning word command is received by the device.

Frequency reference ⁽⁵⁾

Technology Temperature compensated crystal oscillator
 Accuracy $\pm [(\text{aging} \times \text{last adjustment time lapse}) + \text{temp stability} + \text{cal accuracy}]$
 Initial calibration accuracy ± 0.05 ppm
 Temperature stability ⁽⁶⁾
 20 °C to 30 °C ± 0.25 ppm
 0 °C to 55 °C ± 1.0 ppm
 Aging ± 1 ppm for first year @ 25 °C

Frequency accuracy ⁽⁷⁾ $\pm (\text{frequency reference accuracy} * \text{RF input frequency})$ Hz

- (5) The frequency reference refers to the device's internal 10 MHz TCXO time-base. Accuracy is in parts-per-million or ppm (1×10^{-6}).
- (6) Users must apply sufficient cooling to the device to keep the unit temperature as read from its internal temperature sensor within the range of 40 °C to 45 °C at an ambient temperature of 25 °C.
- (7) Accuracy of the device for any given input RF signal.

Sideband noise (dBc/Hz) ⁽⁸⁾⁽⁹⁾

Offset	RF Frequency			
	100 MHz	2000 MHz	4000 MHz	5500 MHz
100 Hz	-80	-78	-76	-74
1 kHz	-95	-93	-91	-89
10 kHz	-100	-97	-95	-93
100 kHz	-112	-110	-110	-109
1 MHz	-139	-138	-138	-137
10 MHz	-150	-149	-147	-145

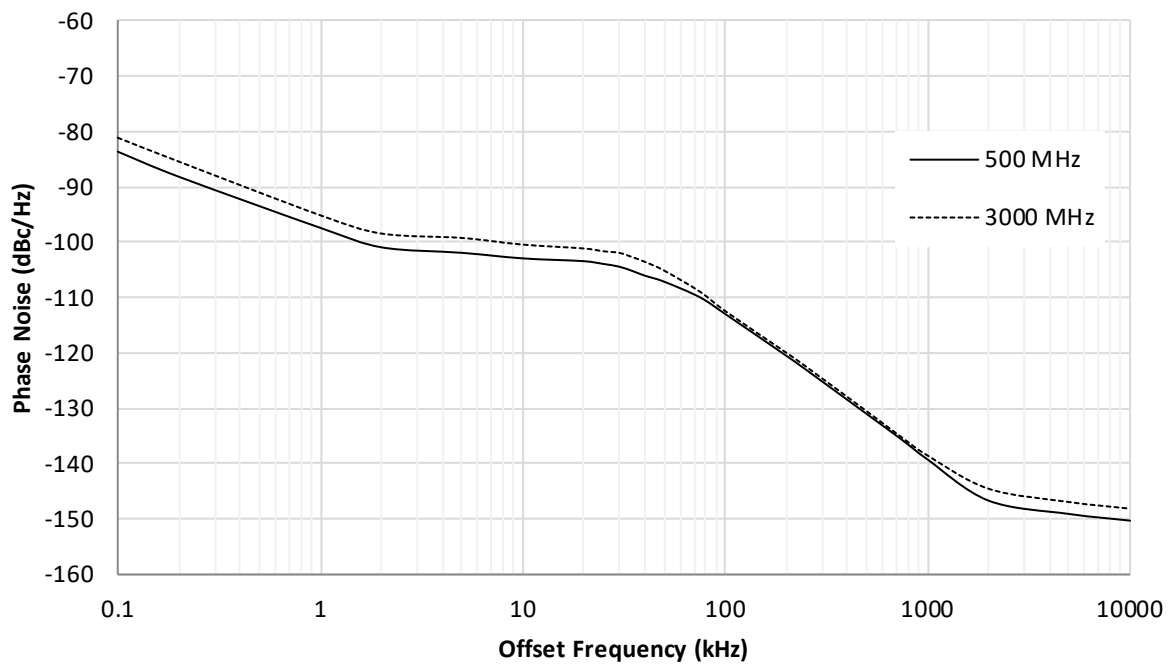


Figure 3. Typical measured sideband noise.⁽⁹⁾

- (8) Sideband phase noise as specified is based on measured sideband noise which includes both phase noise and amplitude noise contributions. Sideband noise is specified for the downconverter when tune mode is set to NORMAL. In FAST-TUNE mode the noise damping capacitor across the YIG tuning coil is disengaged, and thus the close-in phase noise degrades. See the appropriate sections in the user manual for further information on how to set the device to NORMAL or FAST-TUNE modes.
- (9) These results are obtained with input signal levels of 0 dBm at the mixer (no RF attenuation) and the output IF level set to 3 dBm.

LO related sideband spurious signals ⁽¹⁰⁾⁽¹¹⁾

< 200 kHz	-70 dBc
> 200 kHz	-75 dBc

- (10) Sideband spurious signals are those that fall within 2 MHz of the carrier that are direct results of the local oscillators in the device. Sources of sideband spurious signals in the synthesized local oscillators are primarily due to fractional-N spurious products in the PLL's, DDS noise sources, and intermodulation between oscillators within the multiple-loop PLL synthesizers. Fractional-N and DDS spurious products affect spectral region below 200 kHz and intermodulation products affect spectral regions out to a couple MHz.
- (11) As the YIG oscillator is sensitive to magnetic fields, magnetic noise due to electrical fans, supply transformers, and other magnetic field-producing devices may induce sideband noise on the signals when they are placed in close proximity. It is recommended that users exercise good technical judgment when such accessories are needed (e.g., mounting a cooling fan directly onto the RF enclosure of the device).

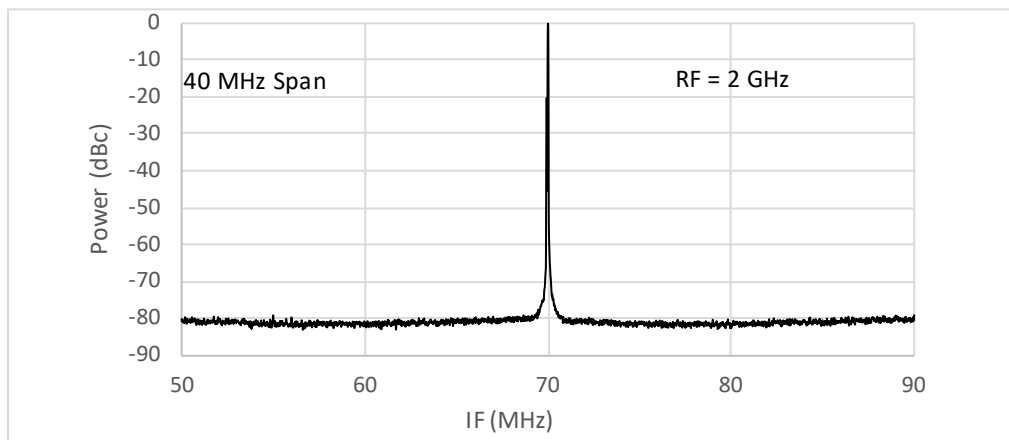


Figure 4 Spectrum at 70 MHz IF of a 2 GHz down converted RF signal; spanned out to 40 MHz

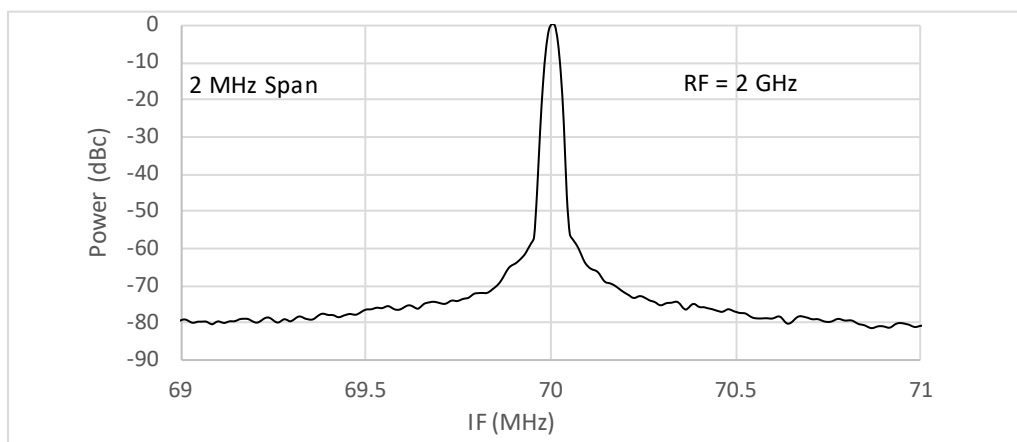


Figure 5 Narrow span of down-converted RF signal centered at 70 MHz IF

Amplitude Specifications

Input range

AC (preamplifier disabled)	+27 dBm max
AC (preamplifier enabled)	+23 dBm max
DC ⁽¹²⁾	0 V

(12) Large and fast DC transients could damage the input solid state devices. Slow ramp up of DC to 10 V is sustainable.

Attenuation range

RF 0 to 60 in 1 dB steps

IF ⁽¹³⁾ 0 to 60 in 0.25 dB steps

Input voltage standing wave ratio (VSWR)

Preamp off, 0 dB input RF attenuation

10 MHz to 3.0 GHz < 1.8

3.0 GHz to 6.0 GHz < 2.5

Preamp on, 0 dB input RF attenuation

10 MHz to 3.0 GHz < 1.8

3.0 GHz to 6.0 GHz < 2.5

Gain range (@ 1GHz) ⁽¹⁴⁾

Minimum ⁽¹⁵⁾ -90 dB typical

Maximum (preamplifier disabled) ⁽¹⁶⁾ 30 dB typical

Maximum (preamplifier enabled) ⁽¹⁶⁾ 45 dB typical

Preamplifier gain 15 dB typical

RF amplitude response (15 °C to 35 °C ambient)

RF gain flatness response (uncorrected) 7 dB typical

RF gain flatness response (corrected) ⁽¹⁷⁾ ± 0.75 dB

Absolute gain accuracy (corrected) ⁽¹⁷⁾ ± 1.0 dB (± 0.75 dB typical)

IF flatness (15 °C to 35 °C ambient)

IF in-band response flatness 3 dB typical

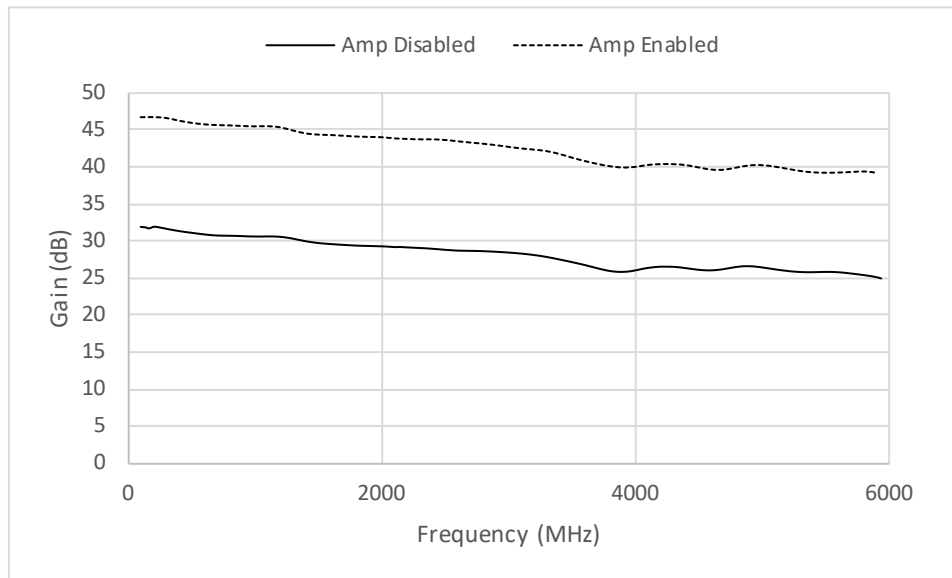


Figure 6. Typical RF conversion gain response @ 25 °C. IF set to 240 MHz, attenuation set to zero.

RF to IF group delay (80% of IF bandwidth)

3 stage conversion	100 ns typical
2 stage conversion	100 ns typical

- (13) There are two IF attenuators in total, each having 30 dB of attenuation. The first attenuator steps at 1 dB, while the last attenuator steps at 0.25 dB.
- (14) These are typical gain specifications. The gain of the device is calibrated and stored in the device calibration EEPROM.
- (15) Minimal gain is specified when all attenuators are set to their maximum values and the RF pre-amplifier is disabled.
- (16) Maximum conversion gain is specified when all the attenuators are set to 0 dB attenuation.
- (17) Correction stored in the calibration EEPROM must be applied properly. Users are not obligated to use the calibration provided, they may devise their own method of calibration and correction should they choose to. User methods of calibration and application may improve on the accuracies specified.
- (18) For broadband signal operation it is recommended that users apply in situ amplitude and phase equalization to the received signal to minimize amplitude and phase errors caused by the device.

Dynamic Range Specifications

Spurious response ⁽¹⁹⁾

Residual spurious signals ⁽²⁰⁾

RF < 1 GHz < -70 dBm

RF > 1 GHz..... < -80 dBm

RF induced spurious signals ⁽²¹⁾ < -65 dBc

Image rejection ⁽²²⁾ < -100 dBc

IF rejection ⁽²³⁾ < -100 dBc

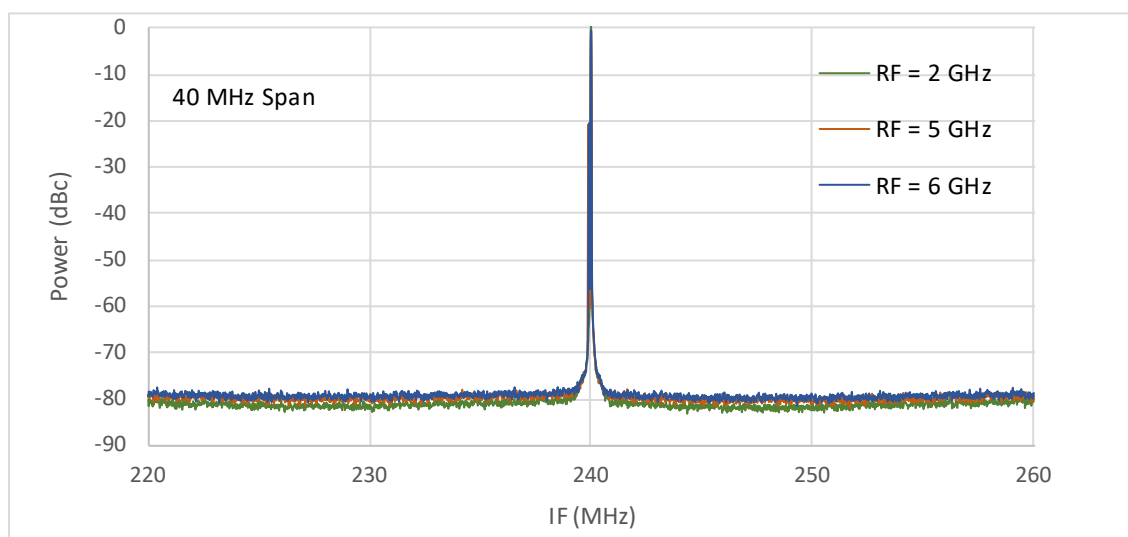


Figure 7. Spectrum showing low spurs for various RF converted frequencies to 240 MHz IF.

- (19) Spurious responses are unwanted signals appearing at the IF output. All spurious products are referenced to the RF input, meaning that they are treated as if they originate at the input port of the device.
- (20) Residual spurious signals are observed and referenced to the RF input of the device when the RF input is terminated with a matched load. The RF attenuators are set to 0 dB attenuation and the final IF attenuators were adjusted to obtain an overall device gain of 20 dB. The preamplifier is disabled.
- (21) LO related spurious signals are unwanted signals produced at the IF output due to inter-modulation of the local oscillators. These spurious signals are measured relative to an RF signal present at the input. The specification referenced here is for a device configuration of -20 dBm at the mixer, 0 dBm at the IF output, and a total gain of 20 dB.
- (22) Image rejection is the ability of the device to reject an image signal of the RF frequency that would otherwise produce the same result as the desired RF signal. The image of the desired RF signal is calculated as $RF_{image} = RF + 2IF_1$, where $IF_1 = 7.6 GHz$.
- (23) IF rejection is the ability of the device to reject RF signals at any of the IF frequencies while the device is tuned elsewhere. Signal level at the mixer is -20 dBm and total gain is 20 dB.

Input noise density (15 °C to 30 °C ambient) ⁽²⁴⁾

Preamplifier disabled ⁽²⁵⁾

	100 MHz	3000 MHz	5500 MHz
Noise floor (dBm/Hz)	-151	-149	-145
Noise figure (dB)	23	25	29

Preamplifier enabled ⁽²⁵⁾

	100 MHz	1000 MHz	5500 MHz
Noise floor (dBm/Hz)	-165	-163	-159
Noise figure (dB)	9	11	15

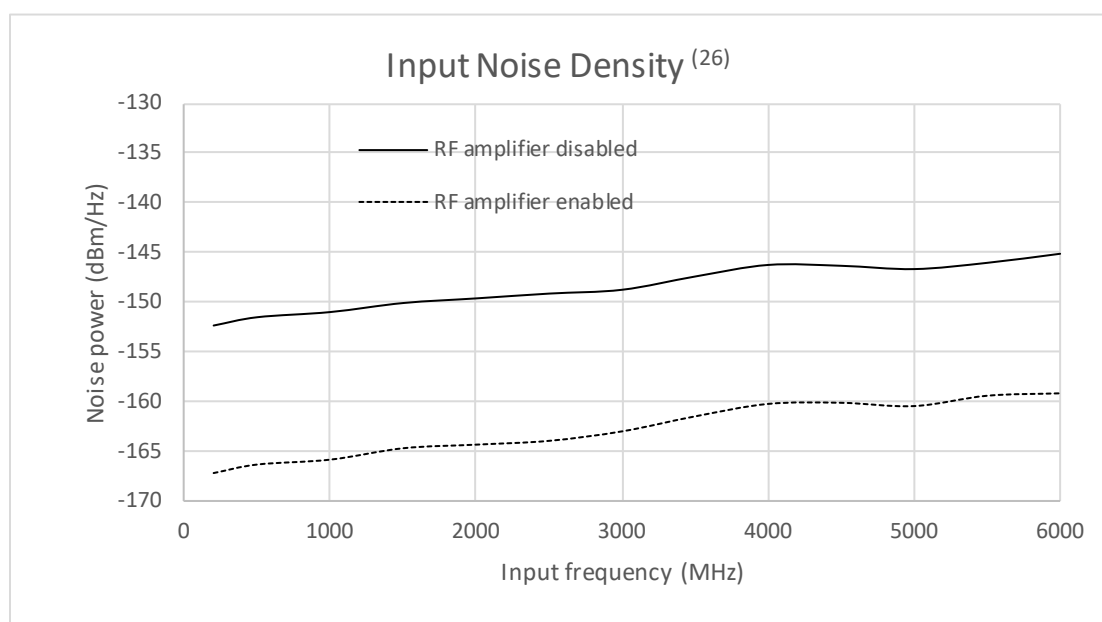


Figure 8. Measured noise density of the average of two lots.

(24) Noise (thermal) is referred to the input of the device.

(25) The device is configured with 0 dB RF attenuation, 0 dB IF1 attenuation, and IF attenuators adjusted to set the gain to 20 dB. This setting is made to be consistent with the configuration for other specifications such as linearity and spurious responses so that the user may obtain a clearer picture of the specified performance of the device. The RF input is terminated with a matched 50 Ω load.

(26) In spectrum analyzer and signal analyzer applications this is also commonly referred to as the Displayed Average Noise Level (DANL). This assumes that the digitizer used does not limit the performance of the device.

Input third-order intermodulation (IIP3, dBm)

	100 MHz – 1.5 GHz	1.5 GHz – 4 GHz	4 GHz – 6 GHz
Preamplifier disabled ⁽²⁷⁾⁽²⁹⁾	15 [16]	16.5 [18]	16 [17]
Preamplifier enabled ⁽²⁸⁾⁽²⁹⁾	-3.0 [-1]	-2.0 [1]	-2.0 [1]

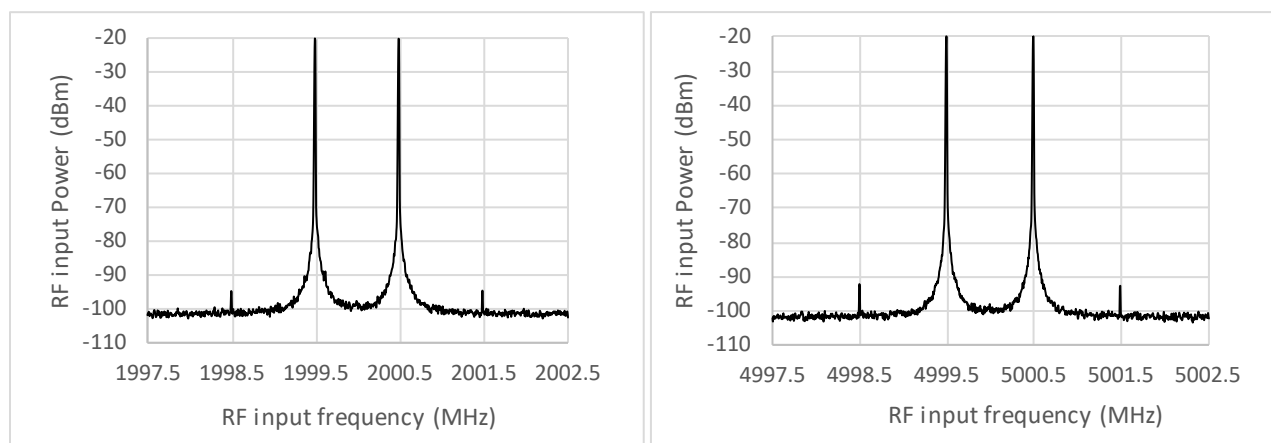


Figure 9. Plots show the typical IMD performance with two -20 dBm signals at the input, 0 dB RF attenuation, preamp disabled, gain of 20 dB, and IF frequency of 240 MHz.

- (27) Specifications are based on 0 dB RF attenuation, 0 dB IF1 attenuation, two -20 dBm tones with 1 MHz separation at the mixer, and final IF attenuators set to maintain 0 dBm at the IF output. The IF frequency is set at 240 MHz.
- (28) Specifications are based on 0 dB RF attenuation, 0 dB IF1 attenuation, two -30 dBm tones with 1 MHz separation at the mixer, and final IF attenuators set to maintain 0 dBm at the IF output. The IF frequency is set at 240 MHz.
- (29) These are in-band measurements and not out-of-band measurements. Out-of-band signal tones exist outside the IF filter bandwidth of the device, and thus may provide better IP3 measurements. However, using in-band signal tones provides better estimation of the device's non-linear effects on broadband signals.

Input second harmonic distortion (SHI, dBm)

Input second harmonic intercept point (dBm)	500 MHz	1000 MHz	2700 MHz
Preamplifier disabled	62	62	58
Preamplifier enabled	32	33	30

Input compression point (dBm)

	100 MHz – 1.5 GHz	1.5 GHz – 4.0 GHz	4.0 GHz – 6.0 GHz
Preamplifier disabled (RF Atten = 0, Gain = 10)	>6	>7	>8
Preamplifier enabled	-23	-20	-19

Dynamic range

Measurement dynamic range ⁽³⁰⁾ > 185 dB
Instantaneous dynamic range ⁽³¹⁾ > 150 dB

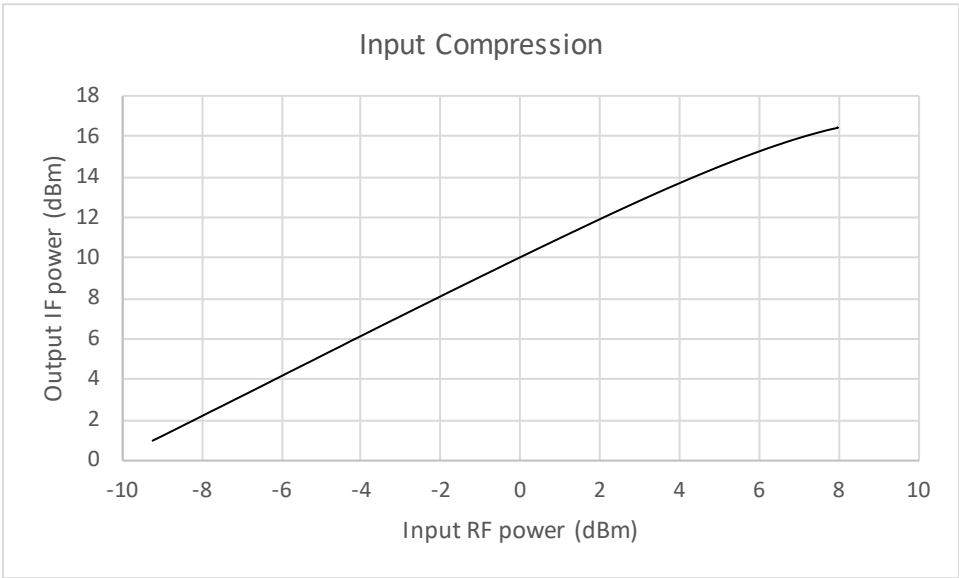


Figure 10. Output IF power vs Input RF power; RF =2 GHz, IF = 240 MHz, gain = 10 dB, RF Atten = 0 dB.

- (30) Measurement dynamic range refers to the device SNR measurement capability using two or more configurations settings. For example, the user could set sufficient RF attenuation to capture the high level signals and then turn on the preamplifier to measure low level noise.

(31) Instantaneous dynamic range refers to the instantaneous device SNR measurement using a single configuration setting. For example, the user could set the downconverter to receive a 0 dBm signal at the mixer, while at the same setting be able to measure the signal noise floor to -150 dB below its peak.

Reference Input and Output Specifications

Reference output specifications

Center frequency ⁽³²⁾	10 MHz/100 MHz
Amplitude	3 dBm typ
Waveform	Sine
Impedance	50 Ω nominal
Coupling	AC
Connector type	SMA female
Frequency accuracy	See “Spectral Specifications” section

Reference input specifications

Center frequency	10 MHz
Amplitude	-3 dBm min/ +10 dBm max
Phase-lock range	± 3 ppm (typ)
Impedance	50 Ω nominal
Coupling	AC
Connector type	SMA female

(32) The output reference frequency may be selected programmatically for 10 MHz or 100 MHz.

Port Specifications

RF input

Input impedance	50 Ω
Coupling	AC
Connector type	SMA female
LO leakage	<-120 dBm

IF output

Output impedance	50 Ω
VSWR	1.6
Coupling	AC
Connector type	SMA female
Output amplitude	20 dBm max

General Specifications

Environmental

Operating temperature ⁽³³⁾	0 °C to +55 °C
Storage temperature	-40 °C to +70 °C
Operating relative humidity	10% to 90%, non-condensing
Storage relative humidity	5% to 90%, non-condensing
Operating shock	30 g, half-sine pulse, 11 ms duration
Storage shock	50 g, half-sine pulse, 11 ms duration
Operating vibration	5 Hz to 500 Hz, 0.31 g _{rms}
Storage vibration	5 Hz to 500 Hz, 2.46 g _{rms}
Altitude	2,000 m maximum (maintaining 25 °C maximum ambient temperature)

Physical

Dimensions (W x H x D, max envelope).....	3.7" x 1.4" x 6.1"
Weight	2.6 lbs
Input voltage (SC5308A)	12 VDC
Power consumption	25 W typical
Communication interface	USB and RS-232/ SPI

Safety Designed to meet the requirements of:
IEC 61010-1, EN 61010-1, UL 61010-1, CSA 61010-1

Electromagnetic Compatibility (EMC) Designed to meet the requirements of:
EN 61326-1 (IEC 61326-1): Class A emissions; Basic immunity 1, EN 55011 (CISPR 11)
Group 1, Class A emissions, AS/NZS CISPR 11: Group 1, Class A emissions, FCC 47 CFR Part 15B: Class A emissions, ICES-001: Class A emissions

CE Meets the requirements of:
2006/95/EC; Low-Voltage Directive (safety), 2004/108/EC; Electromagnetic Compatibility Directive (EMC Directive)

Warranty 3 years parts and labor on defects in materials or workmanship

(33) User-provided cooling solution is required to keep the device less than 15 °C above the ambient temperature.

Revision Notes

Rev 1.0

Original document

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